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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded - Microcontrollers</u>"

Product Status	Active
Core Processor	PIC
Core Size	8-Bit
Speed	20MHz
Connectivity	-
Peripherals	POR, WDT
Number of I/O	12
Program Memory Size	768B (512 x 12)
Program Memory Type	ОТР
EEPROM Size	-
RAM Size	25 x 8
Voltage - Supply (Vcc/Vdd)	4.5V ~ 5.5V
Data Converters	-
Oscillator Type	External
Operating Temperature	0°C ~ 70°C (TA)
Mounting Type	Through Hole
Package / Case	18-DIP (0.300", 7.62mm)
Supplier Device Package	18-PDIP
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/pic16c54-hs-p

PIC16C5X

TABLE 3-2: PINOUT DESCRIPTION - PIC16C55, PIC16C57, PIC16CR57

Din Name	Pi	n Numb	er	Pin	Buffer	Description
Pin Name	DIP	SOIC	SSOP	Туре	Type	Description
RA0	6	6	5	I/O	TTL	Bi-directional I/O port
RA1	7	7	6	I/O	TTL	·
RA2	8	8	7	I/O	TTL	
RA3	9	9	8	I/O	TTL	
RB0	10	10	9	I/O	TTL	Bi-directional I/O port
RB1	11	11	10	I/O	TTL	·
RB2	12	12	11	I/O	TTL	
RB3	13	13	12	I/O	TTL	
RB4	14	14	13	I/O	TTL	
RB5	15	15	15	I/O	TTL	
RB6	16	16	16	I/O	TTL	
RB7	17	17	17	I/O	TTL	
RC0	18	18	18	I/O	TTL	Bi-directional I/O port
RC1	19	19	19	I/O	TTL	
RC2	20	20	20	I/O	TTL	
RC3	21	21	21	I/O	TTL	
RC4	22	22	22	I/O	TTL	
RC5	23	23	23	I/O	TTL	
RC6	24	24	24	I/O	TTL	
RC7	25	25	25	I/O	TTL	
T0CKI	1	1	2	I	ST	Clock input to Timer0. Must be tied to Vss or VDD, if not in use, to reduce current consumption.
MCLR	28	28	28	I	ST	Master clear (RESET) input. This pin is an active low RESET to the device.
OSC1/CLKIN	27	27	27	I	ST	Oscillator crystal input/external clock source input.
OSC2/CLKOUT	26	26	26	0	_	Oscillator crystal output. Connects to crystal or resonator in crystal Oscillator mode. In RC mode, OSC2 pin outputs CLKOUT which has 1/4 the frequency of OSC1, and denotes the instruction cycle rate.
VDD	2	2	3,4	Р	_	Positive supply for logic and I/O pins.
Vss	4	4	1,14	Р		Ground reference for logic and I/O pins.
N/C	3,5	3,5		_		Unused, do not connect.

Legend: I = input, O = output, I/O = input/output, P = power, — = Not Used, TTL = TTL input, ST = Schmitt Trigger input

5.2 Device Reset Timer (DRT)

The Device Reset Timer (DRT) provides an 18 ms nominal time-out on RESET regardless of Oscillator mode used. The DRT operates on an internal RC oscillator. The processor is kept in RESET as long as the DRT is active. The DRT delay allows VDD to rise above VDD min., and for the oscillator to stabilize.

Oscillator circuits based on crystals or ceramic resonators require a certain time after power-up to establish a stable oscillation. The on-chip DRT keeps the device in a RESET condition for approximately 18 ms after the voltage on the MCLR/VPP pin has reached a logic high (VIH) level. Thus, external RC networks connected to the MCLR input are not required in most cases, allowing for savings in cost-sensitive and/or space restricted applications.

The Device Reset time delay will vary from chip to chip due to VDD, temperature, and process variation. See AC parameters for details.

The DRT will also be triggered upon a Watchdog Timer time-out. This is particularly important for applications using the WDT to wake the PIC16C5X from SLEEP mode automatically.

5.3 Reset on Brown-Out

A brown-out is a condition where device power (VDD) dips below its minimum value, but not to zero, and then recovers. The device should be RESET in the event of a brown-out.

To RESET PIC16C5X devices when a brown-out occurs, external brown-out protection circuits may be built, as shown in Figure 5-6, Figure 5-7 and Figure 5-8.

FIGURE 5-6: EXTERNAL BROWN-OUT PROTECTION CIRCUIT 1

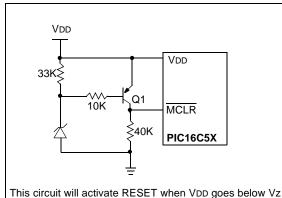
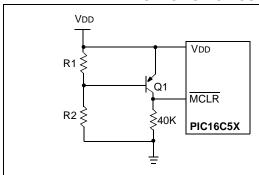


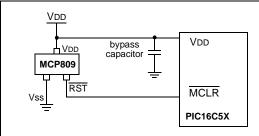
FIGURE 5-7: EXTERNAL BROWN-OUT PROTECTION CIRCUIT 2



This brown-out circuit is less expensive, although less accurate. Transistor Q1 turns off when VDD is below a certain level such that:

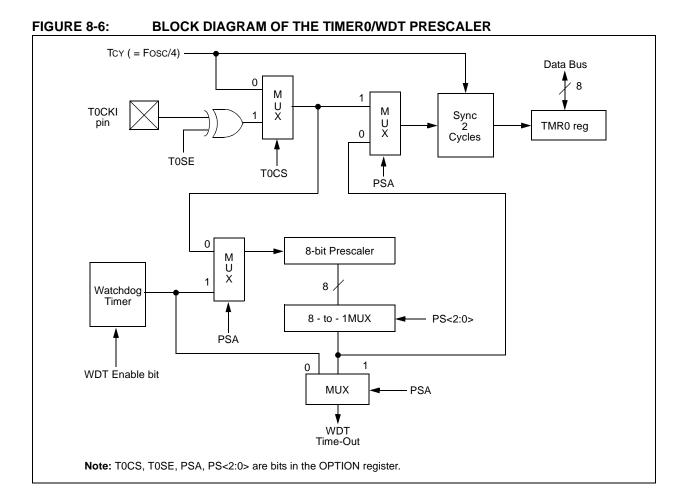
$$V_{DD} \bullet \frac{R1}{R1 + R2} = 0.7V$$

FIGURE 5-8: EXTERNAL BROWN-OUT PROTECTION CIRCUIT 3



This brown-out protection circuit employs Microchip Technology's MCP809 microcontroller supervisor. The MCP8XX and MCP1XX families of supervisors provide push-pull and open collector outputs with both "active high and active low" RESET pins. There are 7 different trip point selections to accommodate 5V and 3V systems.

+ 0.7V (where Vz = Zener voltage).



RLF	Rotate	e Left f	thro	ugh Carry
Syntax:	[label] RLF	f,c	I
Operands:	$0 \le f \le d \in [0]$			
Operation:	See de	escripti	on be	elow
Status Affected:	С			
Encoding:	0011	010	df	ffff
Description:	rotated the Ca is 0 the registe	d one b arry Fla e resuli er. If 'd' back i	oit to t g (ST t is pl is 1 t n	egister 'f' are the left through TATUS<0>). If 'd' aced in the W he result is
Words:	1			
Cycles:	1			
Example:	RLF	REG	1,0	
Before Instru REG1 C After Instruc	=	1110 0	0110	0
REG1 W	=	1110 1100	0110	-
C	=	1	1100	U

RRF	Rotate	e Righ	t f thi	rough Carry
Syntax:	[label	'] RF	RF f,	d
Operands:	$0 \le f \le d \in [0]$			
Operation:	See d	escript	ion be	elow
Status Affected:	С			
Encoding:	0011	. 00	df	ffff
Description:	rotated the Ca is 0 th registe	d one barry Fla e resul er. If 'd' d back	oit to t ag (S7 It is pl is 1 t in	egister 'f' are the right through (ATUS<0>). If 'd' laced in the W the result is
Words:	1			
Cycles:	1			
Example:	RRF	REC	31,0	
Before Instru REG1 C After Instruct REG1	= =	1110 0	0110	
W C	= =	0111 0	0013	1

SLEEP	Enter SL	EEP Mo	de					
Syntax:	[label]	SLEEP						
Operands:	None							
Operation:	$00h \rightarrow W$ $0 \rightarrow \underline{WD}$ $1 \rightarrow \underline{TO}$ $0 \rightarrow PD$,	er; if assi	gned				
Status Affected:	$\overline{TO}, \overline{PD}$							
Encoding:	0000 0000 0011							
Description:	Time-out power-do cleared. caler are The proc mode wit See sect details.	own statu The WDT cleared. essor is p	s bit (PD) and its pout into Sillator sto	is pres- LEEP opped.				
Words:	1							
Cycles:	1							
Example:	SLEEP							

XORLW Exclusive OR literal with W

Syntax: [label] XORLW k

Operands: $0 \le k \le 255$

Operation: (W) .XOR. $k \rightarrow (W)$

Status Affected: Z

Encoding: 1111 kkkk kkkk

Description: The contents of the W register are

XOR'ed with the eight bit literal 'k'. The result is placed in the W regis-

ter.

Words: 1 Cycles: 1

Example: XORLW 0xAF

Before Instruction

W = 0xB5

After Instruction

W = 0x1A

XORWF Exclusive OR W with f

Syntax: [label] XORWF f,d

Operands: $0 \le f \le 31$

 $d \in [0,1]$

Operation: (W) .XOR. (f) \rightarrow (dest)

Status Affected: Z

Encoding: 0001 10df ffff

Description: Exclusive OR the contents of the

W register with register 'f'. If 'd' is 0 the result is stored in the W register. If 'd' is 1 the result is stored

back in register 'f'.

Words: 1 Cycles: 1

Example XORWF REG, 1

Before Instruction

 $\begin{array}{rcl}
\mathsf{REG} & = & \mathsf{0xAF} \\
\mathsf{W} & = & \mathsf{0xB5}
\end{array}$

After Instruction

 $\begin{array}{rcl} REG & = & 0x1A \\ W & = & 0xB5 \end{array}$

TABLE 11-1: DEVELOPMENT TOOLS FROM MICROCHIP

MPLAB® Integrated	> >	> > > > > > >	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	> > > > >	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	S S S S S S	, , , , , , , , , , , , , , , , , , ,		
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MPASM™ Assembler/ MPLINK™ Object Linker ✓		>> > > >	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	> > > >	> > > >	S S S S			
MPLAB® ICE In-Circuit Emulator	> > > >	> > >	> > > >	\$ \$	> >		\ \ \ \ \ \		
ICEPIC™ In-Circuit Emulator	> > >	> > >	\ \\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	\ \ \ \ \ \	\ \ \ \ \ \ \	\	, ,		
MPLAB® ICD In-Circuit Debugger PICSTART® Plus Entry Level Development Programmer PRO MATE® II Universal Device Programmer PICDEM™ 1 Demonstration Board PICDEM™ 2 Demonstration Board PICDEM™ 3 Demonstration Board PICDEM™ 14A Demonstration Board PICDEM™ 14A Demonstration PICDEM™ 15	> >	· · ·	> >	\ \ \ \	> >	, ,	> >		
PICSTART® Plus Entry Level Development Programmer PRO MATE® II Universal Device Programmer PICDEM™ 1 Demonstration Board PICDEM™ 2 Demonstration Board PICDEM™ 3 Demonstration Board PICDEM™ 3 Demonstration Board PICDEM™ 4A Demonstration PICDEM™ 4A Demonstration PICDEM™ 4A Demonstration	> >	> >	> >	> >	> >	, ,	>		
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PICDEM™ 14A Demonstration Board			>						
PICDEM™ 17 Demonstration Board					>				
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microID™ Programmer's Kit									>
5 125 kHz microID™ Developer's Kit									>
125 kHz Anticollision microlD TM Developer's Kit									>
13.56 MHz Anticollision microlD™ Developer's Kit									>
MCP2510 CAN Developer's Kit									

12.4 DC Characteristics: PIC16C54/55/56/57-RC, XT, 10, HS, LP (Commercial) PIC16C54/55/56/57-RCI, XTI, 10I, HSI, LPI (Industrial)

DC CH	ARACTE	RISTICS	Standard O Operating Te		ire 0°C	≤ TA ≤ +	s otherwise specified) -70°C for commercial -85°C for industrial
Param No.	Symbol	Characteristic/Device	Min	Тур†	Max	Units	Conditions
D030	VIL	Input Low Voltage I/O ports MCLR (Schmitt Trigger) T0CKI (Schmitt Trigger) OSC1 (Schmitt Trigger) OSC1 (Schmitt Trigger)	Vss Vss Vss Vss Vss	_ _ _ _	0.2 VDD 0.15 VDD 0.15 VDD 0.15 VDD 0.3 VDD	V V V V	Pin at hi-impedance PIC16C5X-RC only ⁽³⁾ PIC16C5X-XT, 10, HS, LP
D040	ViH	Input High Voltage I/O ports I/O ports I/O ports MCLR (Schmitt Trigger) TOCKI (Schmitt Trigger) OSC1 (Schmitt Trigger) OSC1 (Schmitt Trigger)	0.45 VDD 2.0 0.36 VDD 0.85 VDD 0.85 VDD 0.85 VDD 0.7 VDD		VDD VDD VDD VDD VDD VDD	V V V V V	For all VDD ⁽⁴⁾ 4.0V < VDD ≤ 5.5V ⁽⁴⁾ VDD > 5.5V PIC16C5X-RC only ⁽³⁾ PIC16C5X-XT, 10, HS, LP
D050	VHYS	Hysteresis of Schmitt Trigger inputs	0.15 VDD*	_	_	V	
D060	IIL	Input Leakage Current ^(1,2) I/O ports MCLR MCLR TOCKI OSC1	-1 -5 -3 -3	0.5 — 0.5 0.5 0.5	+1 +5 +3 +3	μΑ μΑ μΑ μΑ μΑ	For Vdd \leq 5.5V: VSS \leq VPIN \leq VDD, pin at hi-impedance VPIN = VSS + 0.25V VPIN = VDD VSS \leq VPIN \leq VDD VSS \leq VPIN \leq VDD, PIC16C5X-XT, 10, HS, LP
D080	Vol	Output Low Voltage I/O ports OSC2/CLKOUT	_	_	0.6 0.6	V V	IOL = 8.7 mA, VDD = 4.5V IOL = 1.6 mA, VDD = 4.5V, PIC16C5X-RC
D090	Voн	Output High Voltage ⁽²⁾ I/O ports OSC2/CLKOUT	VDD - 0.7 VDD - 0.7	_ _		V V	IOH = -5.4 mA, VDD = 4.5V IOH = -1.0 mA, VDD = 4.5V, PIC16C5X-RC

^{*} These parameters are characterized but not tested.

- 2: Negative current is defined as coming out of the pin.
- **3:** For PIC16C5X-RC devices, the OSC1/CLKIN pin is a Schmitt Trigger input. It is not recommended that the PIC16C5X be driven with external clock in RC mode.
- 4: The user may use the better of the two specifications.

[†] Data in the Typical ("Typ") column is based on characterization results at 25°C. This data is for design guidance only and is not tested.

Note 1: The leakage current on the MCLR/VPP pin is strongly dependent on the applied voltage level. The specified levels represent normal operating conditions. Higher leakage current may be measured at different input voltage.

FIGURE 12-5: TIMER0 CLOCK TIMINGS - PIC16C54/55/56/57

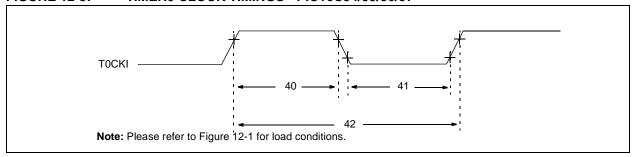


TABLE 12-4: TIMERO CLOCK REQUIREMENTS - PIC16C54/55/56/57

AC Ch	aracterist	Standard Operating (Operating Temperature	•	+70°C f +85°C f	or com or indu	mercial strial	i)
Param No.	Symbol	Characteristic	Min	Тур†	Max	Units	Conditions
40	Tt0H	TOCKI High Pulse Width - No Prescaler - With Prescaler	0.5 Tcy + 20* 10*			ns ns	
41	Tt0L	Tocki Low Pulse Width - No Prescaler - With Prescaler	0.5 TcY + 20* 10*	_	_	ns ns	
42	Tt0P	T0CKI Period	20 or <u>Tcy + 40</u> * N	_	_	ns	Whichever is greater. N = Prescale Value (1, 2, 4,, 256)

These parameters are characterized but not tested.

[†] Data in the Typical ("Typ") column is at 5.0V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

FIGURE 14-17: TRANSCONDUCTANCE (gm) OF LP OSCILLATOR vs. VDD

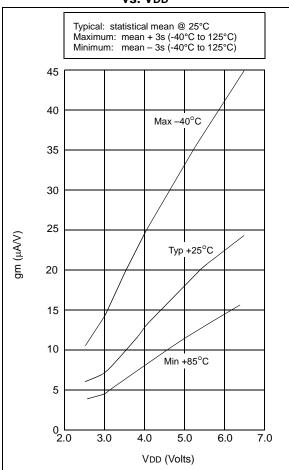
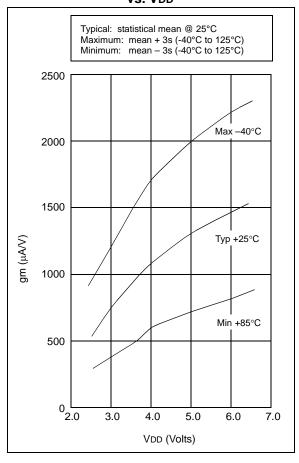


FIGURE 14-18: TRANSCONDUCTANCE (gm) OF XT OSCILLATOR vs. VDD



15.1 DC Characteristics: PIC16C54A-04, 10, 20 (Commercial)
PIC16C54A-04I, 10I, 20I (Industrial)
PIC16LC54A-04 (Commercial)
PIC16LC54A-04I (Industrial)

	54A-04 54A-04I ercial, Ind	ustrial)		ard Ope ting Tem	_	ire	tions (unless otherwise specified) $0^{\circ}C \le TA \le +70^{\circ}C$ for commercial $40^{\circ}C \le TA \le +85^{\circ}C$ for industrial
PIC16C5	54A-04, 10 54A-04I, 1 nercial, Ind	0I, 20I			_	ire	tions (unless otherwise specified) $0^{\circ}C \le TA \le +70^{\circ}C$ for commercial $40^{\circ}C \le TA \le +85^{\circ}C$ for industrial
Param No.	Symbol	Characteristic/Device	Min	Тур†	Max	Units	Conditions
	IPD	Power-down Current ⁽²⁾					
D006		PIC16LC5X		2.5 0.25 2.5 0.25	12 4.0 14 5.0	μΑ μΑ μΑ μΑ	VDD = 2.5V, WDT enabled, Commercial VDD = 2.5V, WDT disabled, Commercial VDD = 2.5V, WDT enabled, Industrial VDD = 2.5V, WDT disabled, Industrial
D006A		PIC16C5X	1111	4.0 0.25 5.0 0.3	12 4.0 14 5.0	μΑ μΑ μΑ μΑ	VDD = 3.0V, WDT enabled, Commercial VDD = 3.0V, WDT disabled, Commercial VDD = 3.0V, WDT enabled, Industrial VDD = 3.0V, WDT disabled, Industrial

Legend: Rows with standard voltage device data only are shaded for improved readability.

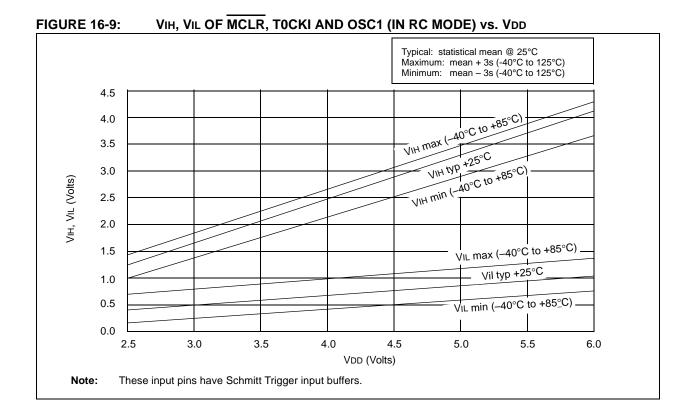
- * These parameters are characterized but not tested.
- † Data in "Typ" column is based on characterization results at 25°C. This data is for design guidance only and is not tested.
- Note 1: This is the limit to which VDD can be lowered in SLEEP mode without losing RAM data.
 - 2: The supply current is mainly a function of the operating voltage and frequency. Other factors such as bus loading, oscillator type, bus rate, internal code execution pattern and temperature also have an impact on the current consumption.
 - a) The test conditions for all IDD measurements in active Operation mode <u>are: OSC1</u> = external square wave, from rail-to-rail; all I/O pins tristated, pulled to Vss, T0CKI = VDD, MCLR = VDD; WDT enabled/disabled as specified.
 - b) For standby current measurements, the conditions are the same, except that the device is in SLEEP mode. The power-down current in SLEEP mode does not depend on the oscillator type.
 - 3: Does not include current through REXT. The current through the resistor can be estimated by the formula: IR = VDD/2REXT (mA) with REXT in $k\Omega$.

15.2 DC Characteristics: PIC16C54A-04E, 10E, 20E (Extended) PIC16LC54A-04E (Extended)

PIC16L (Extend	C54A-04E ded)	Ī	Opera	ting Tem	perati	ire	tions (unless otherwise specified) $-40^{\circ}\text{C} \le \text{TA} \le +125^{\circ}\text{C}$ for extended
PIC16C (Extend	54A-04E, ded)	10E, 20E		ard Ope ting Tem			tions (unless otherwise specified) -40 °C \leq TA \leq +125°C for extended
Param No.	Symbol	Characteristic	Min	Тур†	Max	Units	Conditions
	VDD	Supply Voltage					
D001		PIC16LC54A	3.0 2.5		6.25 6.25	-	XT and RC modes LP mode
D001A		PIC16C54A	3.5 4.5	_	5.5 5.5	V	RC and XT modes HS mode
D002	Vdr	RAM Data Retention Voltage ⁽¹⁾	_	1.5*	_	V	Device in SLEEP mode
D003	VPOR	VDD Start Voltage to ensure Power-on Reset	_	Vss	_	V	See Section 5.1 for details on Power-on Reset
D004	SVDD	VDD Rise Rate to ensure Power-on Reset	0.05*	_	_	V/ms	See Section 5.1 for details on Power-on Reset
	IDD	Supply Current ⁽²⁾					
D010		PIC16LC54A	_	0.5	25	mA	Fosc = 4.0 MHz, VDD = 5.5V, RC ⁽³⁾ and XT modes
			_	11	27	μА	FOSC = 32 kHz, VDD = 2.5V, LP mode, Commercial
			_	11	35	μА	FOSC = 32 kHz, VDD = 2.5V, LP mode, Industrial
			_	11	37	μА	FOSC = 32 kHz, VDD = 2.5V, LP mode, Extended
D010A		PIC16C54A	_	1.8	3.3	mA	Fosc = 4.0 MHz, VDD = 5.5V, RC ⁽³⁾ and XT modes
			_	4.8	10	mA	FOSC = 10 MHz, VDD = 5.5V, HS mode
			_	9.0	20	mA	FOSC = 20 MHz, VDD = 5.5V, HS mode

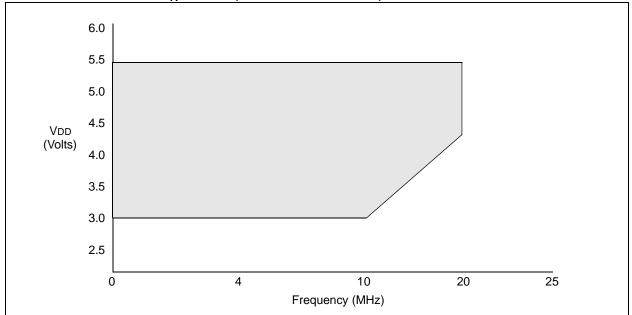
Legend: Rows with standard voltage device data only are shaded for improved readability.

- * These parameters are characterized but not tested.
- † Data in the Typical ("Typ") column is based on characterization results at 25°C. This data is for design guidance only and is not tested.
- Note 1: This is the limit to which VDD can be lowered in SLEEP mode without losing RAM data.
 - 2: The supply current is mainly a function of the operating voltage and frequency. Other factors such as bus loading, oscillator type, bus rate, internal code execution pattern and temperature also have an impact on the current consumption.
 - a) The test conditions for all IDD measurements in active Operation mode are: OSC1 = external square wave, from rail-to-rail; all I/O pins tristated, pulled to Vss, ToCKI = VDD, MCLR = VDD; WDT enabled/disabled as specified.
 - b) For standby current measurements, the conditions are the same, except that the device is in SLEEP mode. The power-down current in SLEEP mode does not depend on the oscillator type.
 - 3: Does not include current through REXT. The current through the resistor can be estimated by the formula: IR = VDD/2REXT (mA) with REXT in $k\Omega$.



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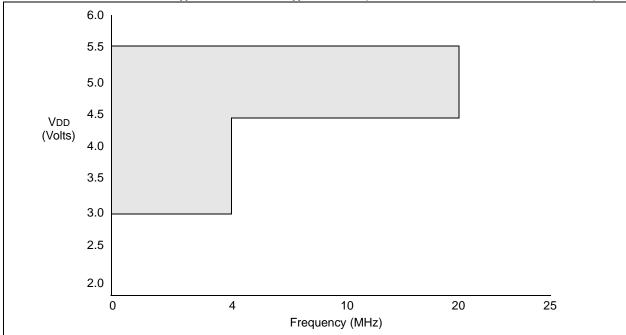
FIGURE 17-1: PIC16C54C/55A/56A/57C/58B-04, 20 VOLTAGE-FREQUENCY GRAPH, $0^{\circ}C \le T_{A} \le +70^{\circ}C$ (COMMERCIAL TEMPS)



Note 1: The shaded region indicates the permissible combinations of voltage and frequency.

2: The maximum rated speed of the part limits the permissible combinations of voltage and frequency. Please reference the Product Identification System section for the maximum rated speed of the parts.

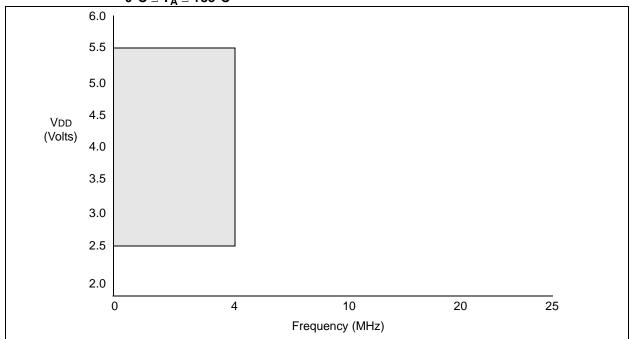
FIGURE 17-2: PIC16C54C/55A/56A/57C/58B-04, 20 VOLTAGE-FREQUENCY GRAPH, $-40^{\circ}C \leq T_A < 0^{\circ}C, +70^{\circ}C < T_A \leq +125^{\circ}C \text{ (OUTSIDE OF COMMERCIAL TEMPS)}$



Note 1: The shaded region indicates the permissible combinations of voltage and frequency.

2: The maximum rated speed of the part limits the permissible combinations of voltage and frequency. Please reference the Product Identification System section for the maximum rated speed of the parts.

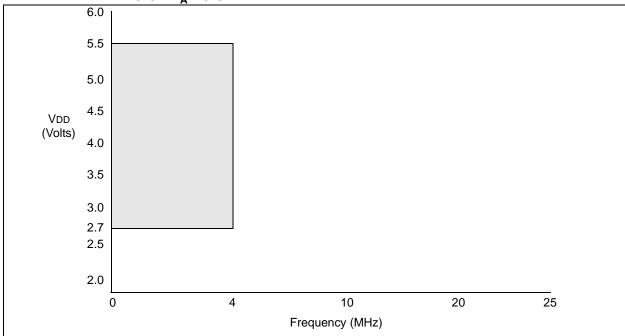
FIGURE 17-3: PIC16LC54C/55A/56A/57C/58B VOLTAGE-FREQUENCY GRAPH, $0^{\circ}C \leq T_{A} \leq +85^{\circ}C$



Note 1: The shaded region indicates the permissible combinations of voltage and frequency.

2: The maximum rated speed of the part limits the permissible combinations of voltage and frequency. Please reference the Product Identification System section for the maximum rated speed of the parts.

FIGURE 17-4: PIC16LC54C/55A/56A/57C/58B VOLTAGE-FREQUENCY GRAPH, $-40^{\circ}\text{C} \leq \text{T}_{\text{A}} \leq 0^{\circ}\text{C}$



Note 1: The shaded region indicates the permissible combinations of voltage and frequency.

2: The maximum rated speed of the part limits the permissible combinations of voltage and frequency. Please reference the Product Identification System section for the maximum rated speed of the parts.

17.1 DC Characteristics:PIC16C54C/C55A/C56A/C57C/C58B-04, 20 (Commercial, Industrial)
PIC16LC54C/LC55A/LC56A/LC57C/LC58B-04 (Commercial, Industrial)
PIC16CR54C/CR56A/CR57C/CR58B-04, 20 (Commercial, Industrial)
PIC16LCR54C/LCR56A/LCR57C/LCR58B-04 (Commercial, Industrial)

PIC16C5	CR5X nercial, Ind	,	Opera Stand	ting Tem	peratu	Condit	ions (unless otherwise specified) $0^{\circ}\text{C} \leq \text{TA} \leq +70^{\circ}\text{C}$ for commercial $-40^{\circ}\text{C} \leq \text{TA} \leq +85^{\circ}\text{C}$ for industrial ions (unless otherwise specified) $0^{\circ}\text{C} \leq \text{TA} \leq +70^{\circ}\text{C}$ for commercial $-40^{\circ}\text{C} \leq \text{TA} \leq +85^{\circ}\text{C}$ for industrial
Param No.	Symbol	Characteristic/Device	Min	Тур†	Max	Units	Conditions
	VDD	Supply Voltage					
D001		PIC16LC5X	2.5 2.7 2.5		5.5 5.5 5.5	V V V	-40°C ≤ TA ≤ + 85°C, 16LCR5X -40°C ≤ TA ≤ 0°C, 16LC5X 0°C ≤ TA ≤ + 85°C 16LC5X
D001A		PIC16C5X	3.0 4.5	_	5.5 5.5	V V	RC, XT, LP and HS mode from 0 - 10 MHz from 10 - 20 MHz
D002	VDR	RAM Data Retention Voltage ⁽¹⁾	_	1.5*	_	V	Device in SLEEP mode
D003	VPOR	VDD Start Voltage to ensure Power-on Reset	_	Vss	_	V	See Section 5.1 for details on Power-on Reset
D004	SVDD	VDD Rise Rate to ensure Power-on Reset	0.05*	_	_	V/ms	See Section 5.1 for details on Power-on Reset

Legend: Rows with standard voltage device data only are shaded for improved readability.

- * These parameters are characterized but not tested.
- † Data in "Typ" column is at 5V, 25°C, unless otherwise stated. These parameters are for design guidance only, and are not tested.
- Note 1: This is the limit to which VDD can be lowered in SLEEP mode without losing RAM data.
 - 2: The supply current is mainly a function of the operating voltage and frequency. Other factors such as bus loading, oscillator type, bus rate, internal code execution pattern and temperature also have an impact on the current consumption.
 - a) The test conditions for all IDD measurements in active Operation mode are: OSC1 = external square wave, from rail-to-rail; all I/O pins tristated, pulled to Vss, T0CKI = VDD, MCLR = VDD; WDT enabled/disabled as specified.
 - b) For standby current measurements, the conditions are the same, except that the device is in SLEEP mode. The power-down current in SLEEP mode does not depend on the oscillator type.
 - 3: Does not include current through REXT. The current through the resistor can be estimated by the formula: IR = VDD/2REXT (mA) with REXT in kΩ.

FIGURE 18-10: VTH (INPUT THRESHOLD TRIP POINT VOLTAGE) OF OSC1 INPUT (IN XT, HS AND LP MODES) vs. VDD

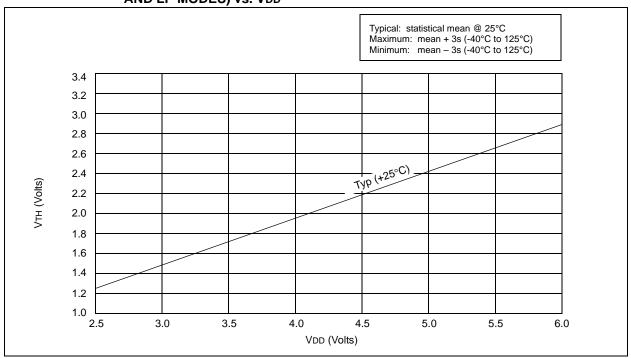
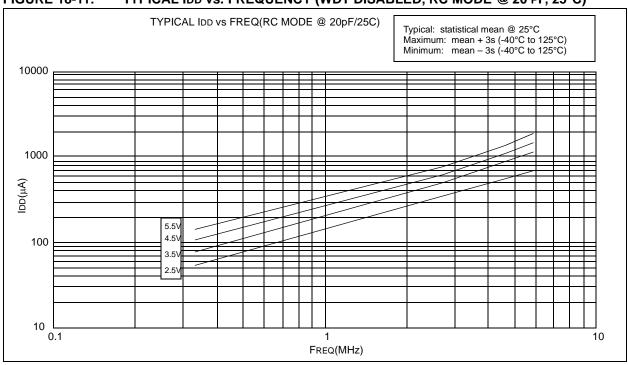


FIGURE 18-11: TYPICAL IDD vs. FREQUENCY (WDT DISABLED, RC MODE @ 20 pF, 25°C)



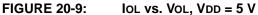
19.1 DC Characteristics:PIC16C54C/C55A/C56A/C57C/C58B-40 (Commercial)⁽¹⁾

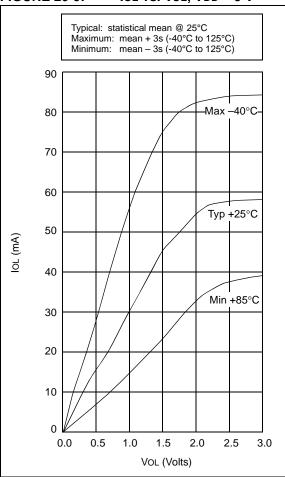
	54C/C55 mercial)	A/C56A/C57C/C58B-40		ard Ope ing Tem	_		tions (unless otherwise specified) $0^{\circ}C \le TA \le +70^{\circ}C$ for commercial
Param No.	Symbol	Characteristic	Min	Тур†	Max	Units	Conditions
D001	VDD	Supply Voltage	4.5	_	5.5	V	HS mode from 20 - 40 MHz
D002	Vdr	RAM Data Retention Voltage ⁽²⁾	_	1.5*	_	V	Device in SLEEP mode
D003	VPOR	VDD Start Voltage to ensure Power-on Reset	_	Vss	_	V	See Section 5.1 for details on Power-on Reset
D004	SVDD	VDD Rise Rate to ensure Power- on Reset	0.05*	_	_	V/ms	See Section 5.1 for details on Power-on Reset
D010	IDD	Supply Current ⁽³⁾	_	5.2 6.8	12.3 16	mA mA	FOSC = 40 MHz, VDD = 4.5V, HS mode FOSC = 40 MHz, VDD = 5.5V, HS mode
D020	IPD	Power-down Current ⁽³⁾	_	1.8 9.8	7.0 27*	μ Α μ Α	VDD = 5.5V, WDT disabled, Commercial VDD = 5.5V, WDT enabled, Commercial

^{*} These parameters are characterized but not tested.

- **Note 1:** Device operation between 20 MHz to 40 MHz requires the following: VDD between 4.5V to 5.5V, OSC1 pin externally driven, OSC2 pin not connected, HS oscillator mode and commercial temperatures. For operation between DC and 20 MHz, See Section 19.1.
 - 2: This is the limit to which VDD can be lowered in SLEEP mode without losing RAM data.
 - **3:** The supply current is mainly a function of the operating voltage and frequency. Other factors such as bus loading, oscillator type, bus rate, internal code execution pattern and temperature also have an impact on the current consumption.
 - a) The test conditions for all IDD measurements in active Operation mode are: OSC1 = external square wave, from rail-to-rail; all I/O pins tristated, pulled to Vss, T0CKI = VDD, MCLR = VDD; WDT enabled/disabled as specified.
 - b) For standby current measurements, the conditions are the same, except that the device is in SLEEP mode. The power-down current in SLEEP mode does not depend on the oscillator type.

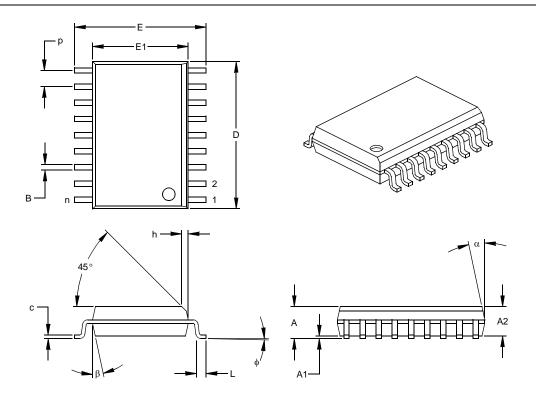
[†] Data in the Typical ("Typ") column is based on characterization results at 25°C. This data is for design guidance only and is not tested.





18-Lead Plastic Small Outline (SO) - Wide, 300 mil (SOIC)

For the most current package drawings, please see the Microchip Packaging Specification located Note: at http://www.microchip.com/packaging



	Units	INCHES*			MILLIMETERS		
Dimension	Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		18			18	
Pitch	р		.050			1.27	
Overall Height	Α	.093	.099	.104	2.36	2.50	2.64
Molded Package Thickness	A2	.088	.091	.094	2.24	2.31	2.39
Standoff §	A1	.004	.008	.012	0.10	0.20	0.30
Overall Width	Е	.394	.407	.420	10.01	10.34	10.67
Molded Package Width	E1	.291	.295	.299	7.39	7.49	7.59
Overall Length	D	.446	.454	.462	11.33	11.53	11.73
Chamfer Distance	h	.010	.020	.029	0.25	0.50	0.74
Foot Length	L	.016	.033	.050	0.41	0.84	1.27
Foot Angle	ф	0	4	8	0	4	8
Lead Thickness	С	.009	.011	.012	0.23	0.27	0.30
Lead Width	В	.014	.017	.020	0.36	0.42	0.51
Mold Draft Angle Top	α	0	12	15	0	12	15
Mold Draft Angle Bottom	β	0	12	15	0	12	15

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed

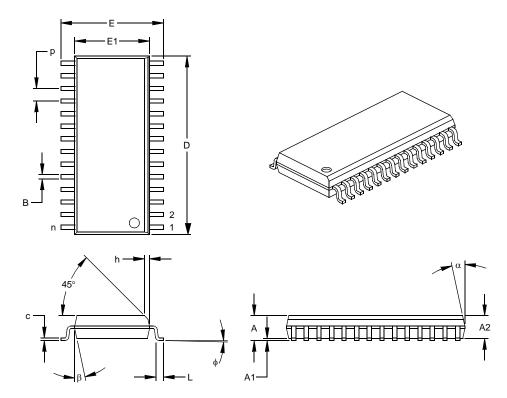
.010" (0.254mm) per side. JEDEC Equivalent: MS-013 Drawing No. C04-051

^{*} Controlling Parameter § Significant Characteristic

28-Lead Plastic Small Outline (SO) - Wide, 300 mil (SOIC)

Note:

For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units	Units INCHES*			MILLIMETERS		
Dimension	Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		28			28	
Pitch	р		.050			1.27	
Overall Height	Α	.093	.099	.104	2.36	2.50	2.64
Molded Package Thickness	A2	.088	.091	.094	2.24	2.31	2.39
Standoff §	A1	.004	.008	.012	0.10	0.20	0.30
Overall Width	Е	.394	.407	.420	10.01	10.34	10.67
Molded Package Width	E1	.288	.295	.299	7.32	7.49	7.59
Overall Length	D	.695	.704	.712	17.65	17.87	18.08
Chamfer Distance	h	.010	.020	.029	0.25	0.50	0.74
Foot Length	L	.016	.033	.050	0.41	0.84	1.27
Foot Angle Top	ф	0	4	8	0	4	8
Lead Thickness	С	.009	.011	.013	0.23	0.28	0.33
Lead Width	В	.014	.017	.020	0.36	0.42	0.51
Mold Draft Angle Top	α	0	12	15	0	12	15
Mold Draft Angle Bottom	β	0	12	15	0	12	15

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed

.010" (0.254mm) per side. JEDEC Equivalent: MS-013 Drawing No. C04-052

^{*} Controlling Parameter § Significant Characteristic